

Notice of References Cited	Application/Control No. 10/549,575	Applicant(s)/Patent Under Reexamination MATSUDA ET AL.	
	Examiner Aline D. McNaul	Art Unit 2872	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0100274 A1	05-2005	Yamashita et al.	385/027
*	B	US-3,498,693	03-1970	MARKIN JOSEPH; et. al.	359/317
*	C	US-3,675,154	07-1972	Duguay et al.	372/33
*	D	US-2003/0021527 A1	01-2003	Mitamura et al.	385/27
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	None				
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	None
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.